

FCC Test Report

Product Name : SATA Flash Drive

Model No. : SFD25H1-M

Applicant : Apacer Technology Inc.

Address : 1F., No.32, Zhongcheng Rd., Tucheng Dist., New Taipei City
236, Taiwan (R.O.C)

Date of Receipt : 2014/04/28

Issued Date : 2014/05/02

Report No. : 1450026R-ITUSP03V00

Report Version : V1.0



The test results relate only to the samples tested.

The test results shown in the test report are traceable to the national/international standard through the calibration of the equipment and evaluated measurement uncertainty herein.

This report must not be used to claim product endorsement by TAF or any agency of the government.

The test report shall not be reproduced without the written approval of Quietek Corporation.

Test Report

Issued Date : 2014/05/02
 Report No. : 1450026R-ITUSP03V00



Product Name : SATA Flash Drive
 Applicant : Apacer Technology Inc.
 Address : 1F., No.32, Zhongcheng Rd., Tucheng Dist., New Taipei City
 236, Taiwan (R.O.C)
 Manufacturer : Apacer Technology Inc.
 Model No. : SFD25H1-M
 EUT Rated Voltage : Power by PC
 EUT Test Voltage : AC 120 V / 60 Hz
 Trade Name : Apacer
 Applicable Standard : FCC CFR Title 47 Part 15 Subpart B: 2013, Class B
 CISPR 22: 2008, ANSI C63.4: 2009
 Test Result : Complied
 Performed Location : Quietek Corporation (Linkou Laboratory)
 No.5-22, Ruishukeng, Linkou Dist., New Taipei City 24451,
 Taiwan, R.O.C.
 TEL:+866-2-8601-3788 / FAX:+886-2-8601-3789

Documented By : Jinn Chen
 (Senior Adm. Specialist / Jinn Chen)

Reviewed By : Leo Lin
 (Senior Engineer / Leo Lin)

Approved By :
 (Director / Vincent Lin)

Laboratory Information

We, **Quietek Corporation**, are an independent EMC and safety consultancy that was established the whole facility in our laboratories. The test facility has been accredited/accepted (audited or listed) by the following related bodies in compliance with ISO 17025, EN 45001 and specified testing scopes:

Taiwan R.O.C.	:	BSMI, NCC, TAF
Norway	:	DNV
USA	:	FCC
Japan	:	VCCI

The related certificate for our laboratories about the test site and management system can be downloaded from Quietek Corporation's Web Site : <http://www.quietek.com/tw/ctg/cts/accreditations.htm>

The address and introduction of Quietek Corporation's laboratories can be founded in our Web site : <http://www.quietek.com/>

If you have any comments, Please don't hesitate to contact us. Our contact information is as below:

HsinChu Testing Laboratory :

No.75-2, 3rd Lin, Wangye Keng, Yonghxing Tsuen, Qionglin Shiang, Hsinchu County 307, Taiwan, R.O.C.

TEL:+886-3-592-8858 / FAX:+886-3-592-8859 E-Mail : service@quietek.com

LinKou Testing Laboratory :

No.5-22, Ruishukeng, Linkou Dist., New Taipei City 24451, Taiwan, R.O.C.

TEL : 886-2-8601-3788 / FAX : 886-2-8601-3789 E-Mail : service@quietek.com

Suzhou (China) Testing Laboratory :

No. 99 Hongye Rd., Suzhou Industrial Park Loufeng Hi-Tech Development Zone., Suzhou,China.

TEL : +86-512-6251-5088 / FAX : +86-512-6251-5098 E-Mail : service@quietek.com

TABLE OF CONTENTS

Description	Page
1. General Information	5
1.1. EUT Description.....	5
1.2. Mode of Operation	6
1.3. Tested System Details	7
1.4. Configuration of Tested System	8
1.5. EUT Exercise Software.....	9
2. Technical Test	10
2.1. Summary of Test Result.....	10
2.2. List of Test Equipment	11
2.3. Measurement Uncertainty.....	12
2.4. Test Environment.....	13
3. Conducted Emission	14
3.1. Test Specification.....	14
3.2. Test Setup.....	14
3.3. Limit.....	14
3.4. Test Procedure	15
3.5. Test Result.....	16
3.6. Test Photograph	22
4. Radiated Emission.....	23
4.1. Test Specification.....	23
4.2. Test Setup.....	23
4.3. Limit.....	24
4.4. Test Procedure	25
4.5. Test Result.....	26
4.6. Test Photograph	30
5. Attachment.....	32
EUT Photograph.....	32

1. General Information

1.1. EUT Description

Product Name	SATA Flash Drive
Trade Name	Apacer
Model No.	SFD25H1-M

1.2. Mode of Operation

QuieTek has verified the construction and function in typical operation. All the test modes were carried out with the EUT in normal operation, which was shown in this test report and defined as:

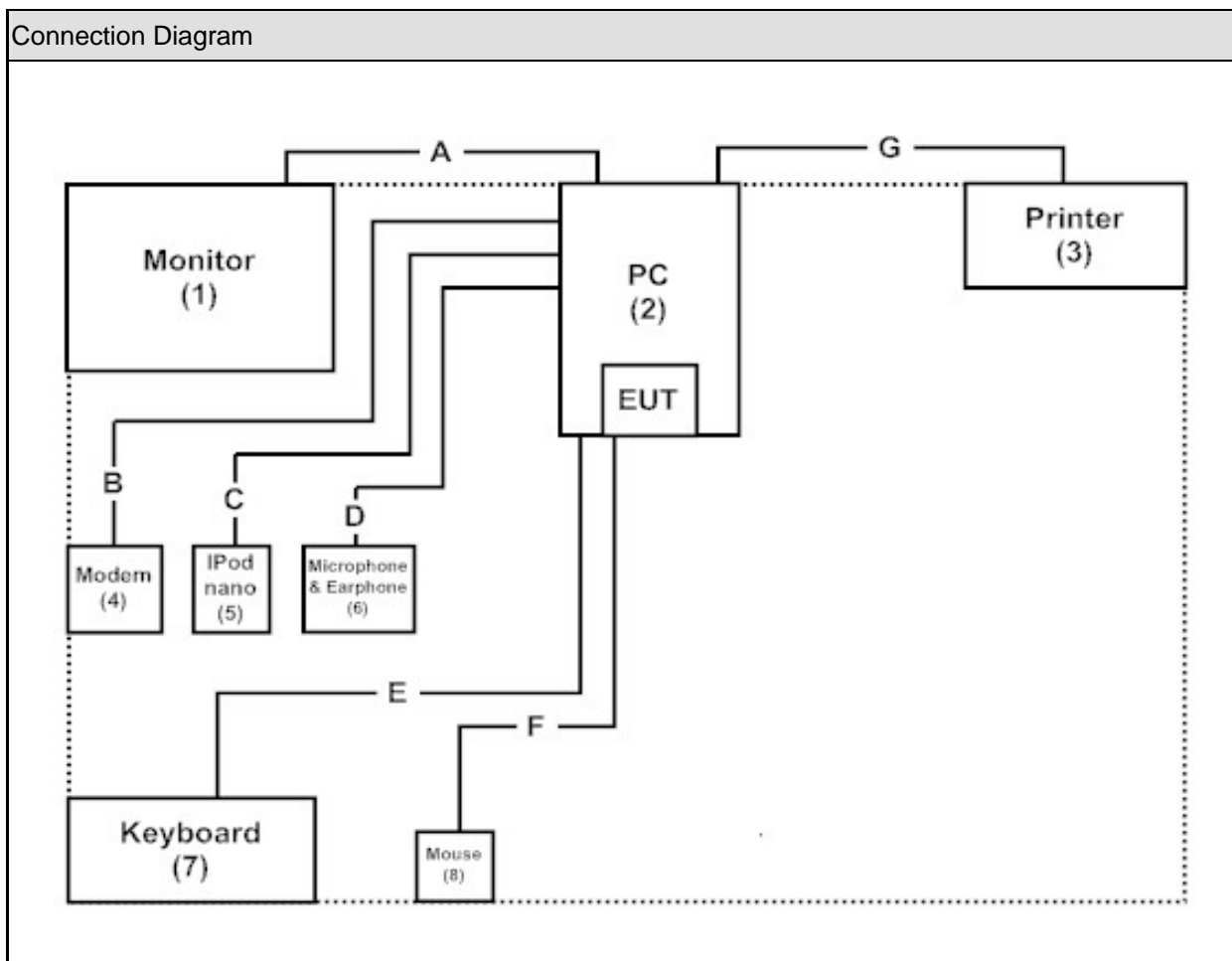
Pre-Test Mode	
Mode 1: Normal Operation	
Final Test Mode	
Emission	Mode 1: Normal Operation

1.3. Tested System Details

The types for all equipments, plus descriptions of all cables used in the tested system (including inserted cards) are:

Product	Manufacturer	Model No.	Serial No.	Power Cord
1 Monitor	DELL	U2410	CN-0J257M-728-011-04NL	Non-Shielded, 1.8m
2 PC	DELL	Vostro230	1R7Z62S	Non-Shielded, 1.8m
3 Printer	EPSON	StyLus C63	FAPY094331	Non-Shielded, 1.8m
4 Modem	ACEEX	DM-1414	0102027554	Non-Shielded, 1.8m
5 IPod nano	Apple	A1236	YM823SUQY0P	N/A
6 Microphone & Earphone	Ergotech	ET-E201	N/A	N/A
7 Keyboard	Logitech	Y-SAL85	SY917UK	N/A
8 Mouse	Logitech	M-SBM96B	810-000440	N/A

1.4. Configuration of Tested System



Signal Cable Type	Signal cable Description
A	D-SUB Cable Shielded, 1.8m, with two ferrite cores bonded.
B	RS-232 Cable Shielded, 1.5m
C	Audio Cable Non-Shielded, 1.6m
D	Microphone & Earphone Cable Non-Shielded, 1.6m
E	Keyboard Cable Shielded, 1.8m
F	Mouse Cable Shielded, 1.8m
G	USB Cable Shielded, 1.8m

1.5. EUT Exercise Software

1	Setup the EUT and simulators as shown on 1.4.
2	Turn on the power of all equipments.
3	All the features of the EUT operation normally.

2. Technical Test

2.1. Summary of Test Result

- No deviations from the test standards
- Deviations from the test standards as below description:

Emission			
Performed Item	Normative References	Test Performed	Deviation
Conducted Emission	FCC CFR Title 47 Part 15 Subpart B: 2013 Class B, ANSI C63.4: 2009	Yes	No
Radiated Emission	FCC CFR Title 47 Part 15 Subpart B: 2013 Class B, ANSI C63.4: 2009	Yes	No

2.2. List of Test Equipment

Conducted Emission / SR2

Instrument	Manufacturer	Type No.	Serial No	Cal. Date
EMI Test Receiver	R&S	ESCI	100648	2013/11/22
LISN	R&S	ESH3-Z5	836679/020	2014/03/18
LISN	R&S	ENV216	100086	2014/04/10
Pulse Limiter	R&S	ESH3-Z2	100324	2014/03/28
Coaxial Cable	QTK(Arnist)	RG 400	LC017-RG	2013/06/26

Radiated Emission / Site2

Instrument	Manufacturer	Type No.	Serial No	Cal. Date
Bilog Antenna	Schaffner Chase	CBL6112B	2921	2013/05/06
EMI Test Receiver	R&S	ESCS 30	100123	2013/07/09
Coaxial Cable	QTK(Arnist)	RG 214	LC002-RG	2013/06/18
Coaxial Switch	Arnist	MP59B	6200436230	2013/06/18
Site2 NSA	QTK	N/A	N/A	2013/06/18

Radiated Emission / CB7

Instrument	Manufacturer	Type No.	Serial No	Cal. Date
EMI Test Receiver	R&S	ESU26	100433	2013/07/29
Horn Antenna	ETS-Lindgren	3117	00135205	2014/03/26
Horn Antenna	SCHWARZBECK	9120D	576	2013/11/20
Pre-Amplifier	Quietek	AP-180C	CHM/071920	2013/06/24
CB7 VSWR	QTK	N/A	N/A	2013/07/25

2.3. Measurement Uncertainty

Conducted Emission

The measurement uncertainty is evaluated as ± 2.26 dB.

Radiated Emission

The measurement uncertainty is evaluated as ± 3.19 dB.

2.4. Test Environment

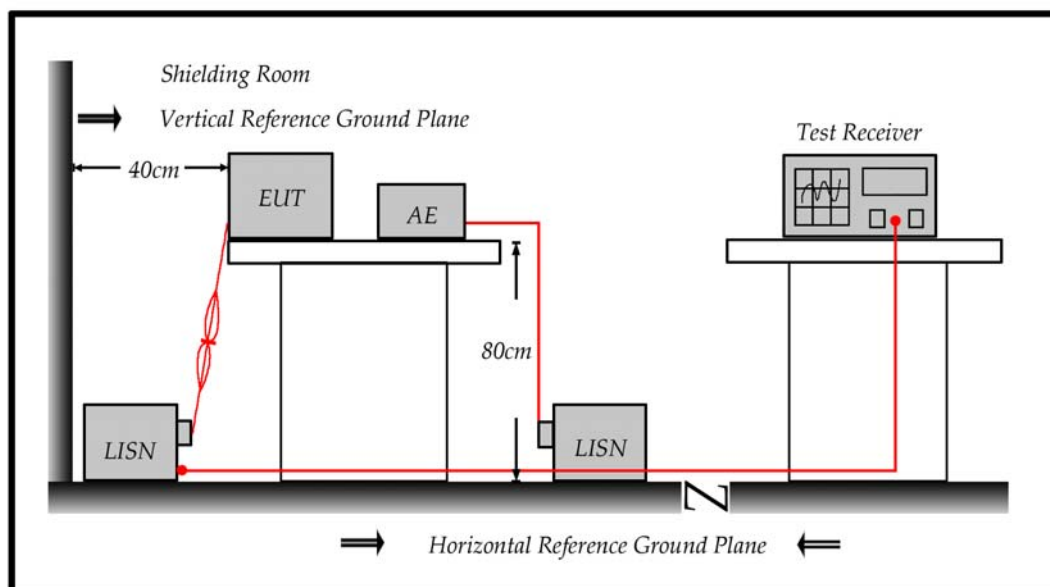
Performed Item	Items	Required	Actual
Conducted Emission	Temperature (°C)	15-35	23.6
	Humidity (%RH)	25-75	53
	Barometric pressure (mbar)	860-1060	950-1000
Radiated Emission	Temperature (°C)	15-35	24.9
	Humidity (%RH)	25-75	38
	Barometric pressure (mbar)	860-1060	950-1000

3. Conducted Emission

3.1. Test Specification

According to Standard : FCC Part 15 Subpart B, ANSI C63.4

3.2. Test Setup



3.3. Limit

Limits		
Frequency (MHz)	QP (dBuV)	AV (dBuV)
0.15 – 0.50	66 – 56	56 – 46
0.50-5.0	56	46
5.0 – 30	60	50

Remarks: In the above table, the tighter limit applies at the band edges.

3.4. Test Procedure

The EUT and simulators are connected to the main power through a line impedance stabilization network (L.I.S.N.). This provides a 50 ohm /50uH coupling impedance for the measuring equipment. The peripheral devices are also connected to the main power through a LISN that provides a 50ohm/50uH coupling impedance with 50ohm termination.

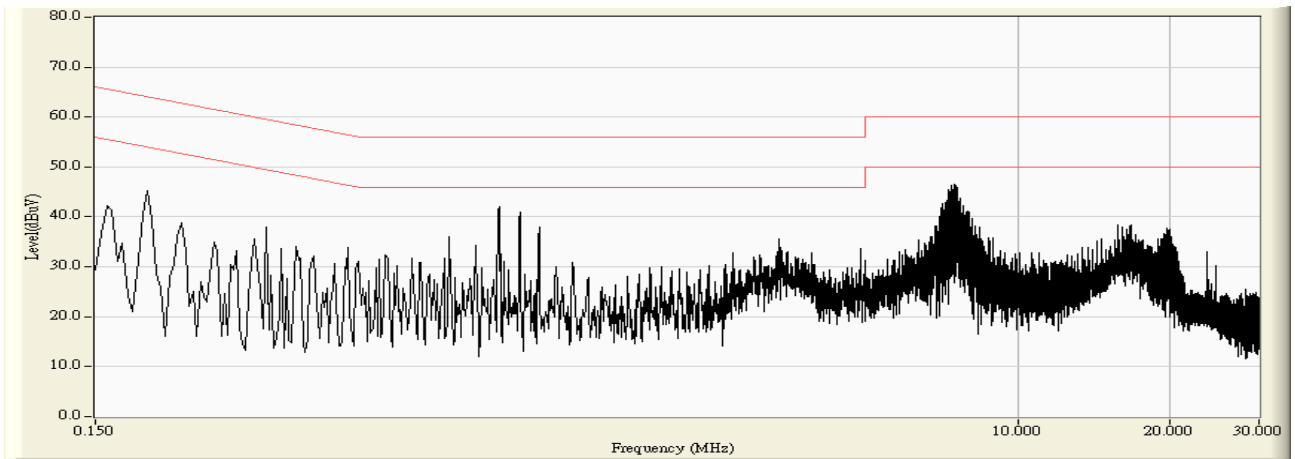
(Please refers to the block diagram of the test setup and photographs.)

Both sides of A.C. line are checked for maximum conducted interference. In order to find the maximum emission, the relative positions of equipment and all of the interface cables must be changed on conducted measurement.

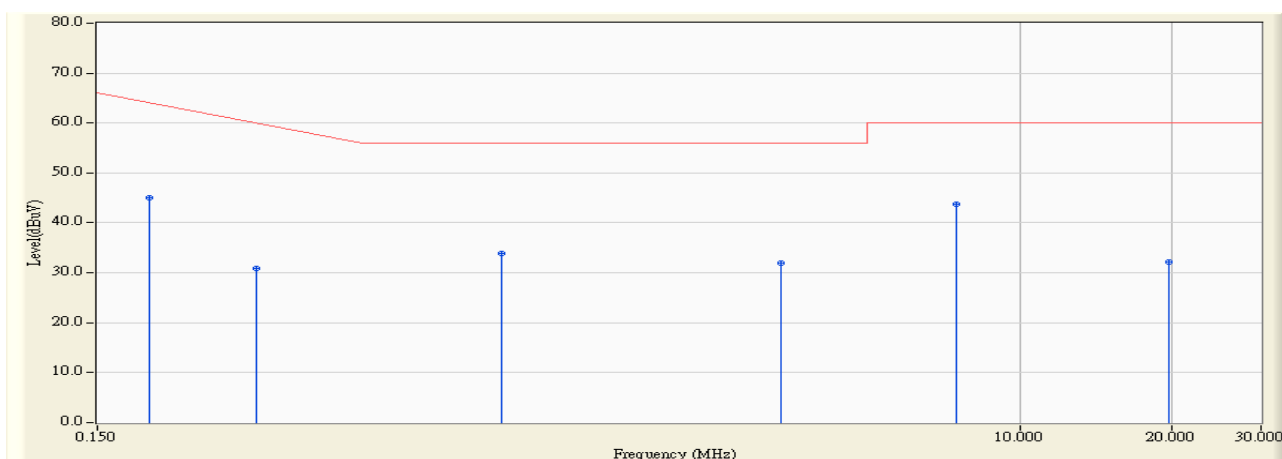
Conducted emissions were invested over the frequency range from 0.15MHz to 30MHz using a receiver bandwidth of 9kHz.

3.5. Test Result

Site : SR2	Time : 2014/04/29 - 09:47
Limit : CISPR_B_00M_QP	Margin : 10
EUT : SATA Flash Drive	Probe : ENV_216_L1 - Line1
Power : AC 120V/60Hz	Note : Mode 1



Site : SR2	Time : 2014/04/29 - 09:49
Limit : CISPR_B_00M_QP	Margin : 0
EUT : SATA Flash Drive	Probe : ENV_216_L1 - Line1
Power : AC 120V/60Hz	Note : Mode 1

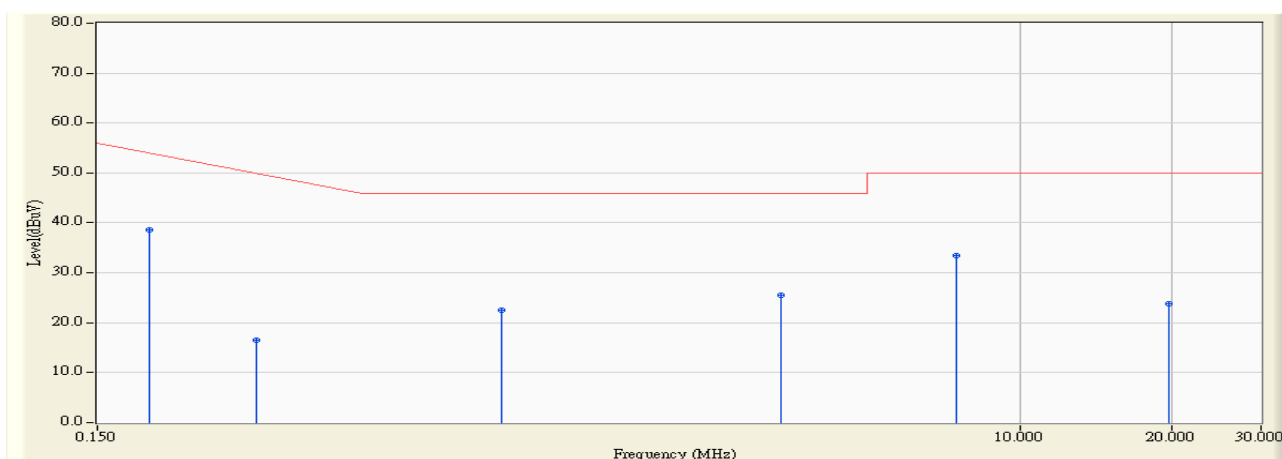


		Frequency (MHz)	Correct Factor (dB)	Reading Level (dBuV)	Measure Level (dBuV)	Margin (dB)	Limit (dBuV)	Detector Type
1		0.190	9.741	35.249	44.990	-19.867	64.857	QUASPEAK
2		0.310	9.741	21.203	30.945	-30.484	61.429	QUASPEAK
3		0.946	9.754	24.213	33.967	-22.033	56.000	QUASPEAK
4		3.382	9.817	22.214	32.032	-23.968	56.000	QUASPEAK
5	*	7.490	9.954	33.839	43.793	-16.207	60.000	QUASPEAK
6		19.690	10.150	22.073	32.223	-27.777	60.000	QUASPEAK

Note:

1. All Reading Levels are Quasi-Peak and average value.
2. " * ", means this data is the worst emission level.
3. Measurement Level = Reading Level + Correct Factor

Site : SR2	Time : 2014/04/29 - 09:49
Limit : CISPR_B_00M_AV	Margin : 0
EUT : SATA Flash Drive	Probe : ENV_216_L1 - Line1
Power : AC 120V/60Hz	Note : Mode 1

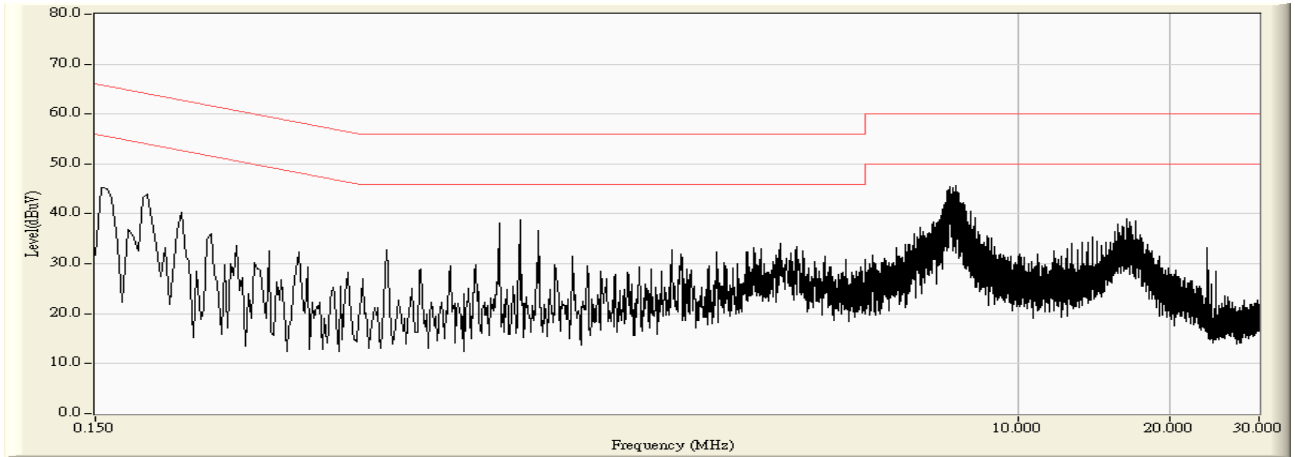


		Frequency (MHz)	Correct Factor (dB)	Reading Level (dBuV)	Measure Level (dBuV)	Margin (dB)	Limit (dBuV)	Detector Type
1	*	0.190	9.741	28.825	38.565	-16.292	54.857	AVERAGE
2		0.310	9.741	6.786	16.528	-34.901	51.429	AVERAGE
3		0.946	9.754	12.802	22.556	-23.444	46.000	AVERAGE
4		3.382	9.817	15.709	25.527	-20.473	46.000	AVERAGE
5		7.490	9.954	23.448	33.402	-16.598	50.000	AVERAGE
6		19.690	10.150	13.552	23.702	-26.298	50.000	AVERAGE

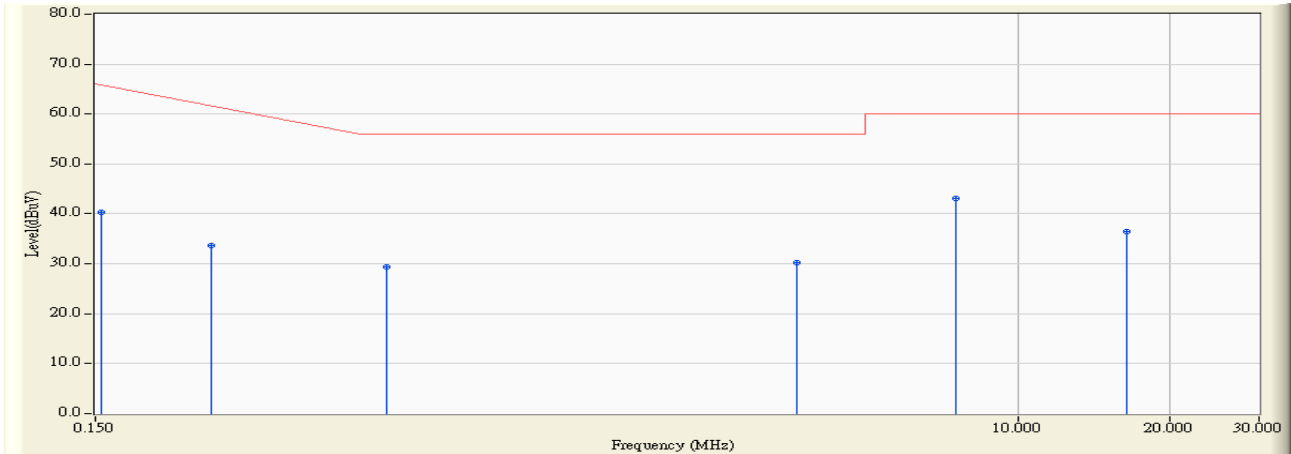
Note:

1. All Reading Levels are Quasi-Peak and average value.
2. " * ", means this data is the worst emission level.
3. Measurement Level = Reading Level + Correct Factor

Site : SR2	Time : 2014/04/29 - 09:49
Limit : CISPR_B_00M_QP	Margin : 10
EUT : SATA Flash Drive	Probe : ENV_216_N - Line2
Power : AC 120V/60Hz	Note : Mode 1



Site : SR2	Time : 2014/04/29 - 09:51
Limit : CISPR_B_00M_QP	Margin : 0
EUT : SATA Flash Drive	Probe : ENV_216_N - Line2
Power : AC 120V/60Hz	Note : Mode 1

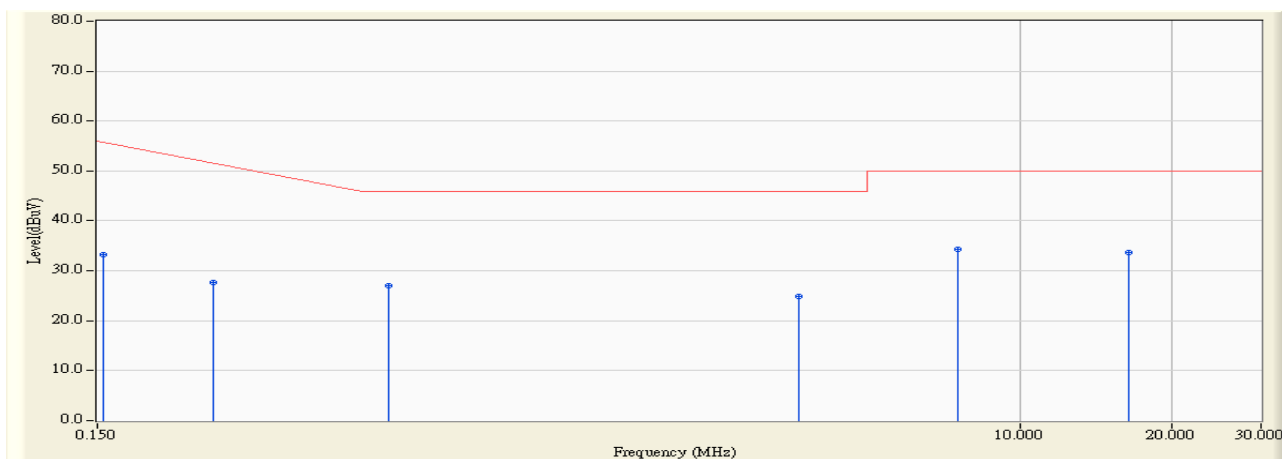


		Frequency (MHz)	Correct Factor (dB)	Reading Level (dBuV)	Measure Level (dBuV)	Margin (dB)	Limit (dBuV)	Detector Type
1		0.154	9.743	30.673	40.415	-25.471	65.886	QUASIPeAK
2		0.254	9.731	24.030	33.761	-29.268	63.029	QUASIPeAK
3		0.566	9.733	19.674	29.407	-26.593	56.000	QUASIPeAK
4		3.662	9.816	20.467	30.284	-25.716	56.000	QUASIPeAK
5	*	7.550	9.961	33.236	43.198	-16.802	60.000	QUASIPeAK
6		16.470	10.240	26.200	36.440	-23.560	60.000	QUASIPeAK

Note:

1. All Reading Levels are Quasi-Peak and average value.
2. " * ", means this data is the worst emission level.
3. Measurement Level = Reading Level + Correct Factor

Site : SR2	Time : 2014/04/29 - 09:51
Limit : CISPR_B_00M_AV	Margin : 0
EUT : SATA Flash Drive	Probe : ENV_216_N - Line2
Power : AC 120V/60Hz	Note : Mode 1



		Frequency (MHz)	Correct Factor (dB)	Reading Level (dBuV)	Measure Level (dBuV)	Margin (dB)	Limit (dBuV)	Detector Type
1		0.154	9.743	23.426	33.169	-22.717	55.886	AVERAGE
2		0.254	9.731	17.979	27.710	-25.319	53.029	AVERAGE
3		0.566	9.733	17.281	27.013	-18.987	46.000	AVERAGE
4		3.662	9.816	14.982	24.798	-21.202	46.000	AVERAGE
5	*	7.550	9.961	24.338	34.299	-15.701	50.000	AVERAGE
6		16.470	10.240	23.518	33.758	-16.242	50.000	AVERAGE

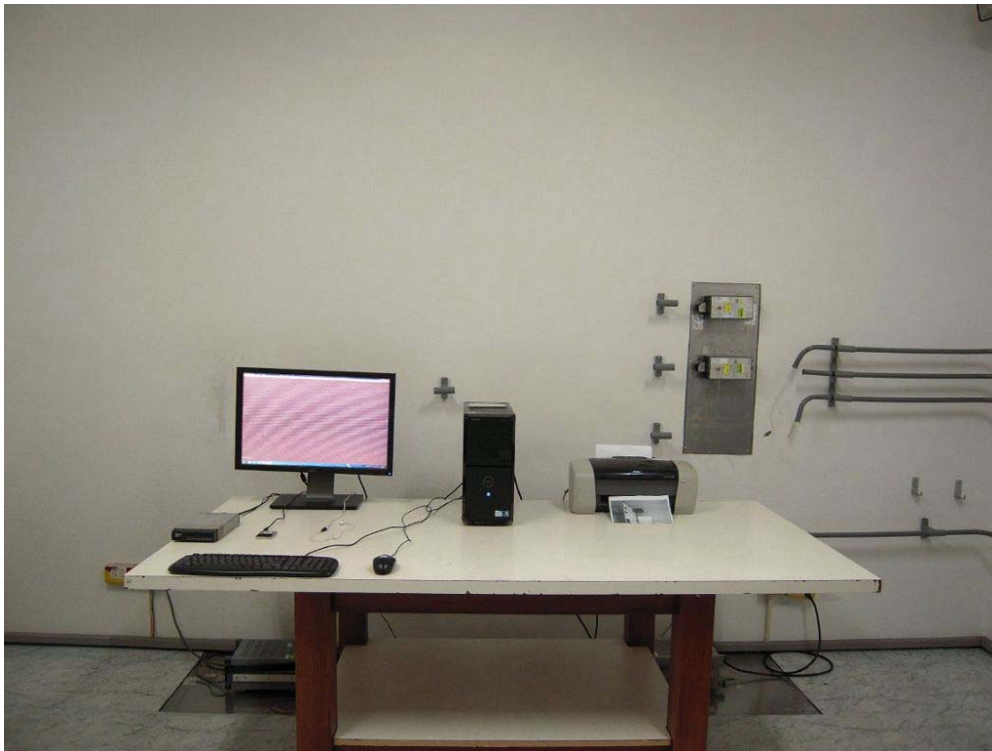
Note:

1. All Reading Levels are Quasi-Peak and average value.
2. " * ", means this data is the worst emission level.
3. Measurement Level = Reading Level + Correct Factor

3.6. Test Photograph

Test Mode : Mode 1: Normal Operation

Description : Front View of Conducted Test



Test Mode : Mode 1: Normal Operation

Description : Back View of Conducted Test



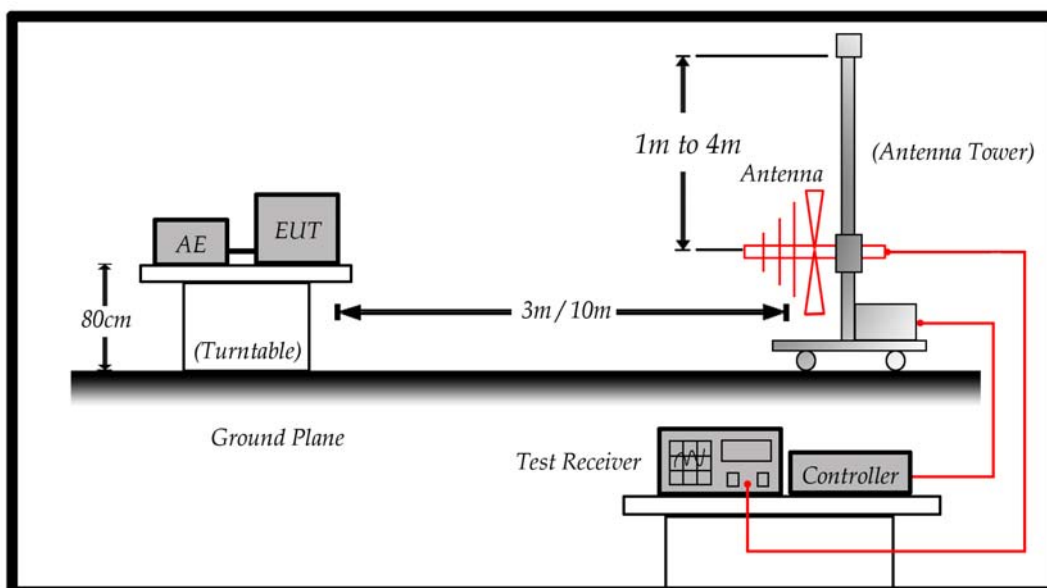
4. Radiated Emission

4.1. Test Specification

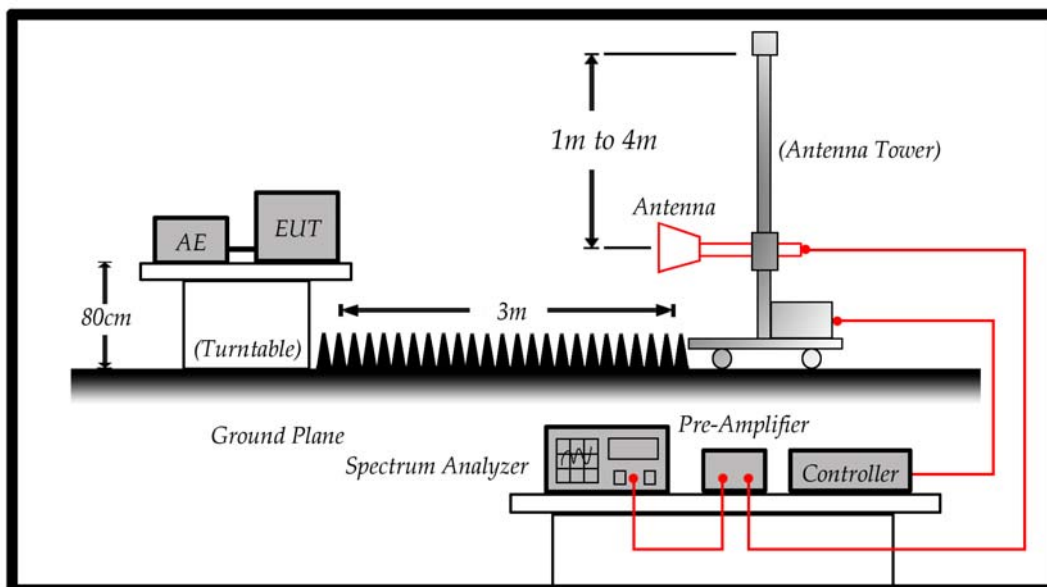
According to EMC Standard : FCC Part 15 Subpart B, ANSI C63.4

4.2. Test Setup

Under 1GHz Test Setup:



Above 1GHz Test Setup:



4.3. Limit

Under 1GHz test shall not exceed the following value:

Limits		
Frequency (MHz)	Distance (m)	dBuV/m
30 – 230	10	30
230 – 1000	10	37

Remark:

1. The tighter limit shall apply at the edge between two frequency bands.
2. Distance refers to the distance in meters between the measuring instrument antenna and the closed point of any part of the device or system.

Above 1GHz test shall not exceed the following value:

FCC Part 15 Subpart B Paragraph 15.109 Limits (dBuV/m)		
Frequency (MHz)	Distance (m)	dBuV/m
30-88	3	40
88-216	3	43.5
216-960	3	46
Above 960	3	54

Remark:

1. The tighter limit shall apply at the edge between two frequency bands.
2. Distance refers to the distance in meters between the measuring instrument antenna and the closed point of any part of the device or system.
3. RF Voltage (dBuV/m) = 20 log RF Voltage (uV/m)

4.4. Test Procedure

The EUT and its simulators are placed on a turn table which is 0.8 meter above ground.

The turn table can rotate 360 degrees to determine the position of the maximum emission level and the antenna can move up and down between 1 meter and 4 meters to find out the maximum emission level.

Both horizontal and vertical polarization of the antenna are set on measurement. In order to find the maximum emission, all of the interface cables must be manipulated on radiated measurement.

For an unintentional radiator, including a digital device, the spectrum shall be investigated from the lowest radio frequency signal generated or used in the device, without going below the lowest frequency for which a radiated emission limit is specified, up to the frequency shown in the following table:

Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Below 1.705	30
1.705 – 108	1000
108 – 500	2000
500 – 1000	5000
Above 1000	5 th harmonic of the highest frequency or 40 GHz, whichever is lower

On any frequency or frequencies below or equal to 1000 MHz, the radiated limits shown are based on measuring equipment employing a quasi-peak detector function and above 1000 MHz, the radiated limits shown are based measuring equipment employing an average detector function.

When average radiated emission measurement are included emission measurement Above 1000 MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20 dB above the maximum permitted average limit.

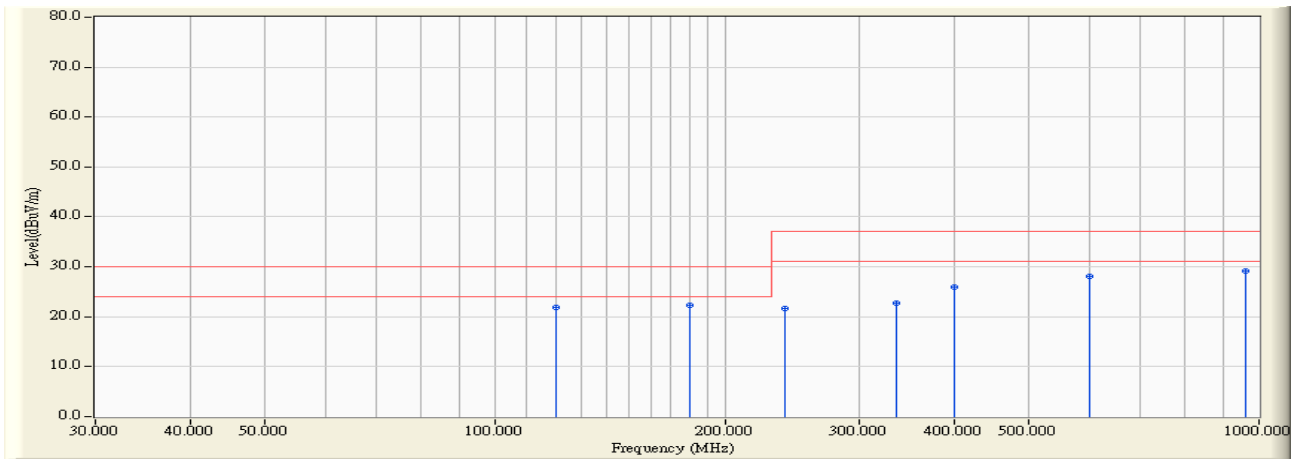
For class A, the measurement distance between the EUT and antenna is 10 meters for under 1GHz and above 1GHz.

For class B, the measurement distance between the EUT and antenna is 10 meters for under 1GHz and 3 meters for above 1GHz.

The bandwidth below 1GHz setting on the field strength meter (R&S Test Receiver ESCS 30) is 120 kHz and above 1GHz is 1MHz.

4.5. Test Result

Site : Site2	Time : 2014/04/28 - 14:42
Limit : CISPR_B_10M_QP	Margin : 6
EUT : SATA Flash Drive	Probe : Site2_CBL6112_10M_2705 - HORIZONTAL
Power : AC 120V/60Hz	Note : Mode 1

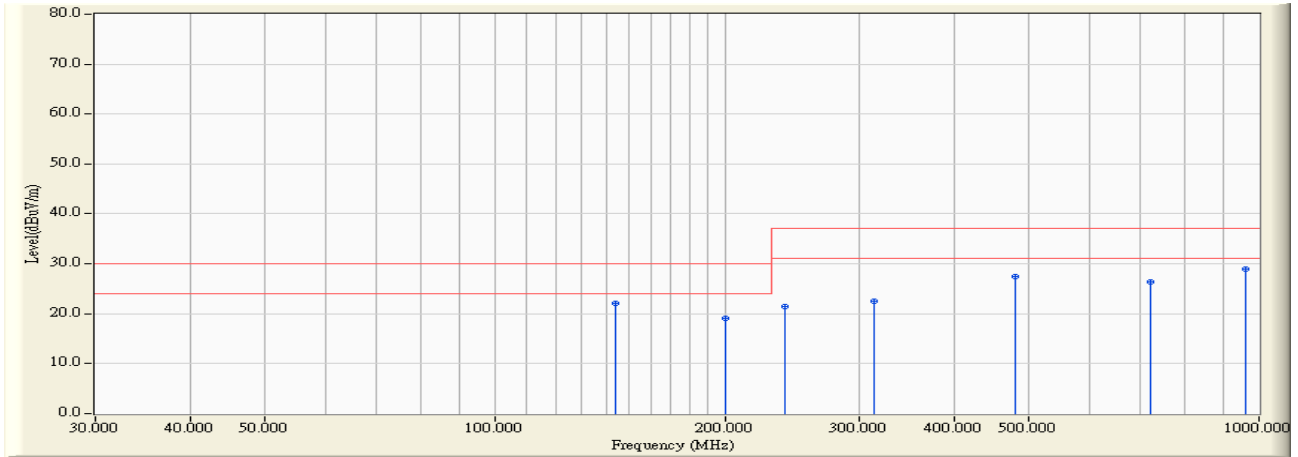


		Frequency (MHz)	Correct Factor (dB)	Reading Level (dBuV)	Measure Level (dBuV/m)	Margin (dB)	Limit (dBuV/m)	Detector Type
1		120.000	14.686	7.100	21.786	-8.214	30.000	QUASIPeAK
2	*	180.000	12.200	10.100	22.301	-7.699	30.000	QUASIPeAK
3		240.000	14.914	6.700	21.614	-15.386	37.000	QUASIPeAK
4		336.000	18.389	4.400	22.789	-14.211	37.000	QUASIPeAK
5		400.000	20.599	5.400	25.999	-11.001	37.000	QUASIPeAK
6		600.000	24.800	3.200	28.000	-9.000	37.000	QUASIPeAK
7		960.000	28.818	0.300	29.118	-7.882	37.000	QUASIPeAK

Note:

1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
2. " * ", means this data is the worst emission level.
3. Measurement Level = Reading Level + Correct Factor

Site : Site2	Time : 2014/04/28 - 15:02
Limit : CISPR_B_10M_QP	Margin : 6
EUT : SATA Flash Drive	Probe : Site2_CBL6112_10M_2705 - VERTICAL
Power : AC 120V/60Hz	Note : Mode 1

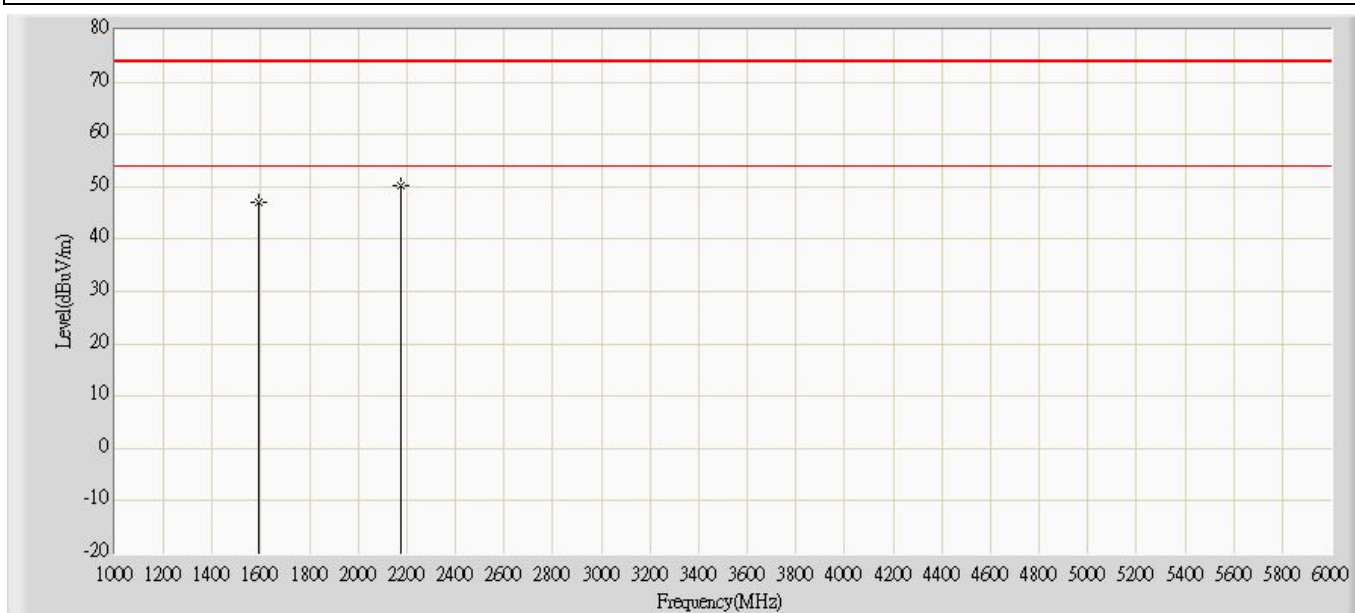


		Frequency (MHz)	Correct Factor (dB)	Reading Level (dBuV)	Measure Level (dBuV/m)	Margin (dB)	Limit (dBuV/m)	Detector Type
1	*	144.000	13.513	8.600	22.113	-7.887	30.000	QUASIPeAK
2		200.460	12.597	6.500	19.097	-10.903	30.000	QUASIPeAK
3		240.000	14.914	6.500	21.414	-15.586	37.000	QUASIPeAK
4		313.200	17.629	4.900	22.529	-14.471	37.000	QUASIPeAK
5		480.000	22.617	4.800	27.418	-9.582	37.000	QUASIPeAK
6		720.000	25.837	0.600	26.437	-10.563	37.000	QUASIPeAK
7		960.000	28.818	0.100	28.918	-8.082	37.000	QUASIPeAK

Note:

1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
2. " * ", means this data is the worst emission level.
3. Measurement Level = Reading Level + Correct Factor

Site: CB7	Time: 2014/04/28 - 19:19
Limit: FCC_B_(Above_1G)	Margin: 0
Probe: CB7_Horn_9120D_1311	Polarity: Horizontal
EUT : SATA Flash Drive	Power: AC 120V/60Hz
Note : Mode 1	

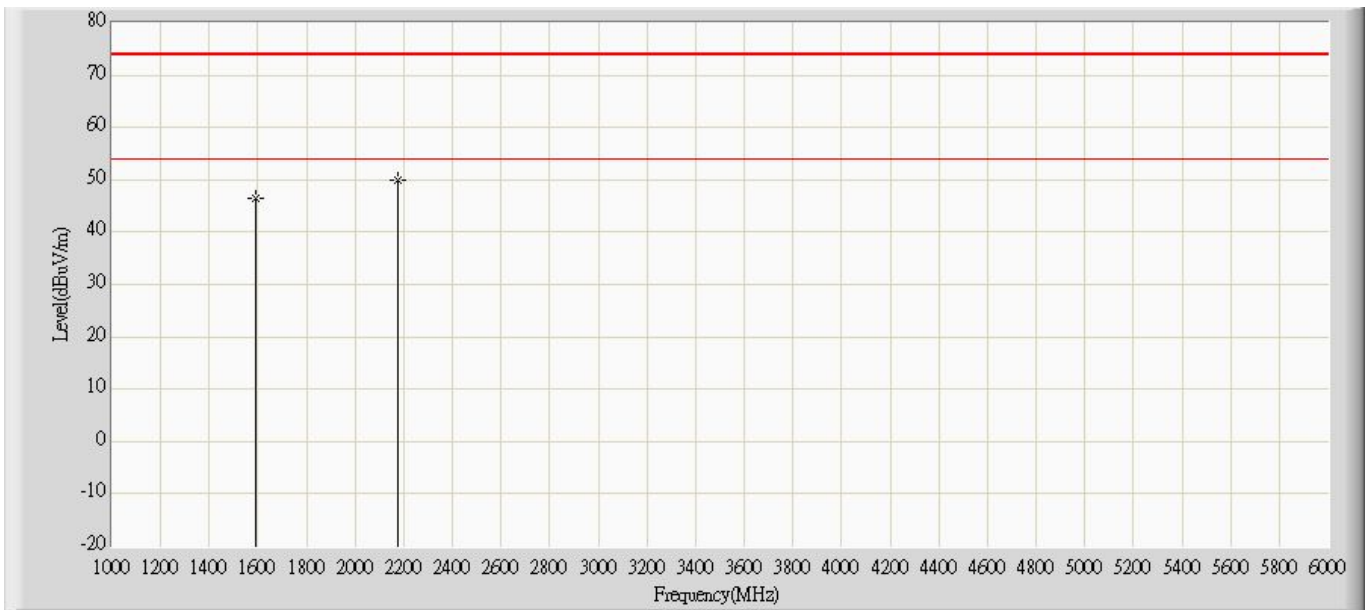


No	Flag	Mark	Frequency (MHz)	Measure Level (dBuV/m)	Reading Level (dBuV)	Over Limit (dB)	Limit (dBuV/m)	Factor	Type
1			1591.000	47.194	49.880	-26.806	74.000	-2.686	PK
2		*	2177.000	50.202	50.260	-23.798	74.000	-0.058	PK

Note:

1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
2. " * ", means this data is the worst emission level.
3. Measurement Level = Reading Level + Factor(Probe+Cable-Amp).

Site: CB7	Time: 2014/04/28 - 19:19
Limit: FCC_B_(Above_1G)	Margin: 0
Probe: CB7_Horn_9120D_1311	Polarity: Vertical
EUT : SATA Flash Drive	Power: AC 120V/60Hz
Note : Mode 1	



No	Flag	Mark	Frequency (MHz)	Measure Level (dBuV/m)	Reading Level (dBuV)	Over Limit (dB)	Limit (dBuV/m)	Factor	Type
1			1592.000	46.572	49.240	-27.428	74.000	-2.667	PK
2		*	2175.000	50.056	50.120	-23.944	74.000	-0.064	PK

Note:

1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
2. " * ", means this data is the worst emission level.
3. Measurement Level = Reading Level + Factor(Probe+Cable-Amp).

4.6. Test Photograph

Test Mode : Mode 1: Normal Operation

Description : Front View of Radiated Test



Test Mode : Mode 1: Normal Operation

Description : Back View of Radiated Test



Test Mode : Mode 1: Normal Operation

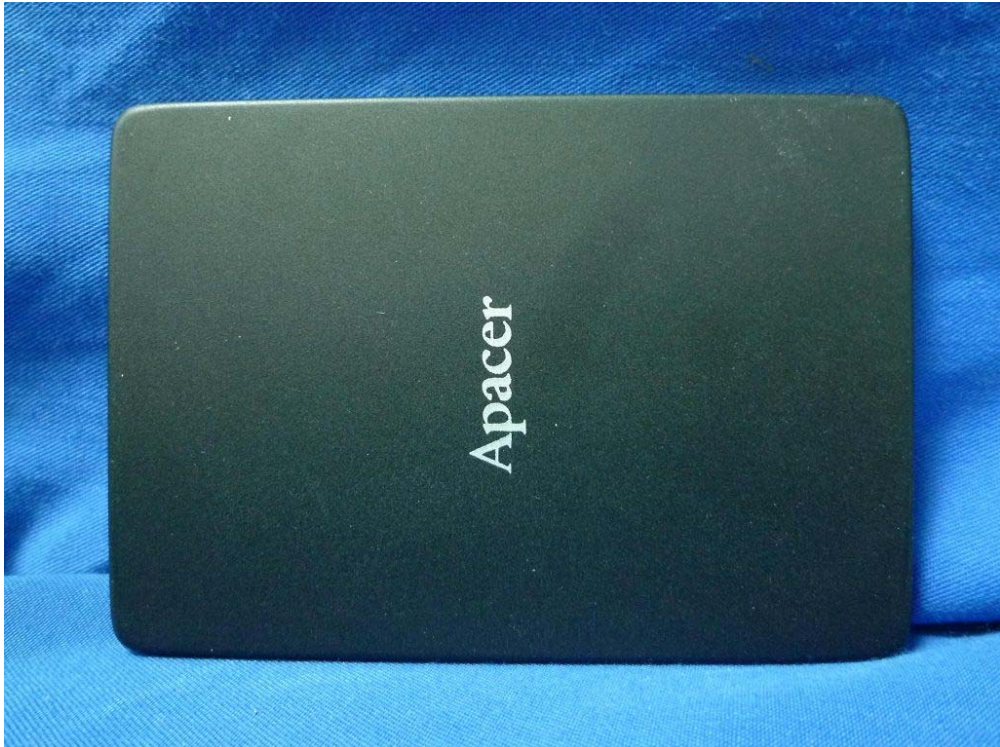
Description : Front View of High Frequency Radiated Test



5. Attachment

➤ EUT Photograph

(1) EUT Photo



(2) EUT Photo



(3) EUT Photo

